

# February 2012 UniFET<sup>TM</sup>

# FDA24N50F

# N-Channel MOSFET 500V, 24A, $0.2\Omega$

## **Features**

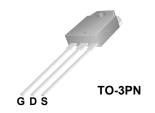
- $R_{DS(on)}$  = 0.166 $\Omega$  ( Typ.)@  $V_{GS}$  = 10V,  $I_D$  = 12A
- Low Gate Charge (Typ. 65nC)
- Low C<sub>rss</sub> ( Typ. 32pF)
- · Fast Switching
- · 100% Avalanche Tested
- · Improved dv/dt Capability
- · RoHS Compliant

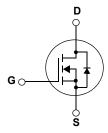


# **Description**

These N-Channel enhancement mode power field effect transistors are produced using Fairchild's proprietary, planar stripe, DMOS technology.

This advance technology has been especially tailored to minimize on-state resistance, provide superior switching performance, and withstand high energy pulse in the avalanche and commutation mode. These devices are well suited for high efficient switching mode power supplies and active power factor correction.





# MOSFET Maximum Ratings T<sub>C</sub> = 25°C unless otherwise noted

Symbol		Parameter		Ratings	Units
V <sub>DSS</sub>	Drain to Source Voltage			500	V
V <sub>GSS</sub>	Gate to Source Voltage			±30	V
	-Continuous ( $T_C = 25^{\circ}C$ )			24	Δ.
ID	Drain Current	-Continuous (T <sub>C</sub> = 100°C)		14	A
I <sub>DM</sub>	Drain Current	- Pulsed	- Pulsed (Note 1)		
E <sub>AS</sub>	Single Pulsed Avalanche Ene	ergy	(Note 2)	1872	mJ
I <sub>AR</sub>	Avalanche Current (N		(Note 1)	24	Α
E <sub>AR</sub>	Repetitive Avalanche Energy		(Note 1)	27	mJ
dv/dt	Peak Diode Recovery dv/dt		(Note 3)	20	V/ns
n	Davies Dissination	$(T_C = 25^{\circ}C)$		270	W
$P_{D}$	Power Dissipation	- Derate above 25°C		2.2	W/°C
T <sub>J</sub> , T <sub>STG</sub>	Operating and Storage Tempo	erature Range		-55 to +150	°C
T <sub>L</sub>	Maximum Lead Temperature for Soldering Purpose, 1/8" from Case for 5 Seconds			300	°C

## **Thermal Characteristics**

Symbol	Parameter	Ratings	Units	
$R_{\theta JC}$	Thermal Resistance, Junction to Case 0.46			
$R_{\theta CS}$	Thermal Resistance, Case to Sink Typ. 0.24			
$R_{\theta JA}$	Thermal Resistance, Junction to Ambient 40			

# **Package Marking and Ordering Information**

Device Marking	Device	Package	Reel Size	Tape Width	Quantity
FDA24N50F	FDA24N50F	TO-3PN	-	-	30

# Electrical Characteristics T<sub>C</sub> = 25°C unless otherwise noted

Symbol	Parameter	Test Conditions	Min.	Тур.	Max.	Units
Off Charac	cteristics					
BV <sub>DSS</sub>	Drain to Source Breakdown Voltage	$I_D = 250 \mu A$ , $V_{GS} = 0 V$ , $T_J = 25 ^{\circ} C$	500	-	-	V
$\frac{\Delta BV_{DSS}}{\Delta T_{J}}$	Breakdown Voltage Temperature Coefficient	I <sub>D</sub> = 250μA, Referenced to 25°C	-	0.6	-	V/°C
1	Zero Gate Voltage Drain Current	V <sub>DS</sub> = 500V, V <sub>GS</sub> = 0V	-	-	1	
IDSS	Zero Gate voltage Drain Current	$V_{DS} = 400V, T_{C} = 125^{\circ}C$	-	-	10	μА
I <sub>GSS</sub>	Gate to Body Leakage Current	$V_{GS} = \pm 30V, V_{DS} = 0V$	-	-	±100	nA

## **On Characteristics**

V <sub>GS(th)</sub>	Gate Threshold Voltage	$V_{GS} = V_{DS}, I_{D} = 250 \mu A$	3.0	-	5.0	V
R <sub>DS(on)</sub>	Static Drain to Source On Resistance	$V_{GS} = 10V, I_D = 12A$	-	0.166	0.2	Ω
9 <sub>FS</sub>	Forward Transconductance	$V_{DS} = 20V, I_D = 12A$ (Note 4)	-	30	-	S

# **Dynamic Characteristics**

C <sub>iss</sub>	Input Capacitance	V <sub>DS</sub> = 25V, V <sub>GS</sub> = 0V f = 1MHz		3240	4310	pF
C <sub>oss</sub>	Output Capacitance			450	600	pF
C <sub>rss</sub>	Reverse Transfer Capacitance	1 - 1101112	-	32	48	pF
Q <sub>g(tot)</sub>	Total Gate Charge at 10V		-	65	85	nC
$Q_{gs}$	Gate to Source Gate Charge	$V_{DS} = 400V, I_{D} = 24A$	-	18	-	nC
Q <sub>gd</sub>	Gate to Drain "Miller" Charge	$V_{GS} = 10V$ (Note 4, 5	-	26	-	nC

# **Switching Characteristics**

t <sub>d(on)</sub>	Turn-On Delay Time			-	49	108	ns
t <sub>r</sub>	Turn-On Rise Time	$V_{DD} = 250V, I_{D} = 24A$		-	105	220	ns
t <sub>d(off)</sub>	Turn-Off Delay Time	$R_G = 25\Omega$		-	165	340	ns
t <sub>f</sub>	Turn-Off Fall Time		(Note 4, 5)	-	87	185	ns

### **Drain-Source Diode Characteristics**

$I_S$	Maximum Continuous Drain to Source Diode Forward Current			-	-	24	Α
I <sub>SM</sub>	Maximum Pulsed Drain to Source Diode Forward Current			-	-	96	Α
$V_{SD}$	Drain to Source Diode Forward Voltage V <sub>GS</sub> = 0V, I <sub>SD</sub> = 24A			-	-	1.4	V
t <sub>rr</sub>	Reverse Recovery Time	V <sub>GS</sub> = 0V, I <sub>SD</sub> = 24A		-	264	-	ns
Q <sub>rr</sub>	Reverse Recovery Charge $dI_F/dt = 100A/\mu s$ (Note 4)		ote 4)	-	1.4	-	μС

#### Notes:

- Repetitive Rating: Pulse width limited by maximum junction temperature
- 2. L = 6.5mH,  $I_{AS}$  = 24A,  $V_{DD}$  = 50V,  $R_{G}$  = 25 $\Omega$ , Starting  $T_{J}$  = 25°C
- 3. I\_{SD}  $\leq$  24A, di/dt  $\leq$  200A/µs, V\_{DD}  $\leq$  BV\_DSS, Starting T\_J = 25°C
- 4. Pulse Test: Pulse width  $\leq 300 \mu s$ , Duty Cycle  $\leq 2\%$
- 5. Essentially Independent of Operating Temperature Typical Characteristics

# **Typical Performance Characteristics**

Figure 1. On-Region Characteristics

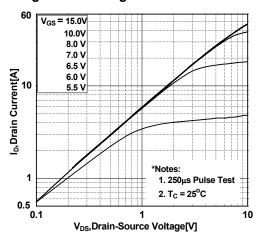


Figure 3. On-Resistance Variation vs.
Drain Current and Gate Voltage

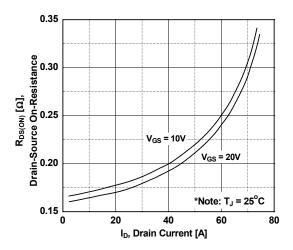


Figure 5. Capacitance Characteristics

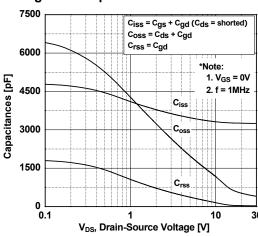


Figure 2. Transfer Characteristics

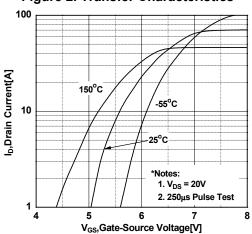


Figure 4. Body Diode Forward Voltage Variation vs. Source Current and Temperature

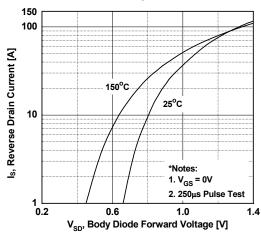
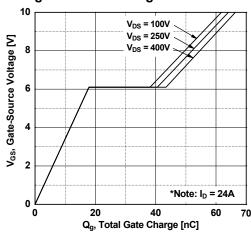


Figure 6. Gate Charge Characteristics



# **Typical Performance Characteristics** (Continued)

Figure 7. Breakdown Voltage Variation vs. Temperature

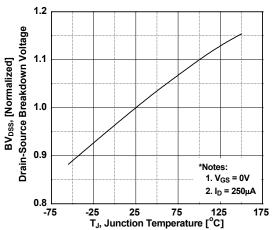


Figure 8. On-Resistance Variation vs. Temperature

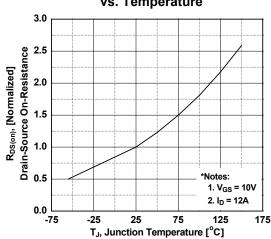


Figure 9. Maximum Safe Operating Area

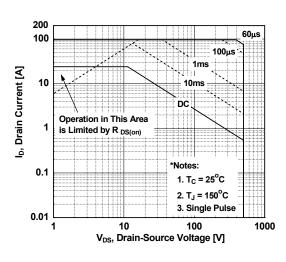


Figure 10. Maximum Drain Current vs. Case Temperature

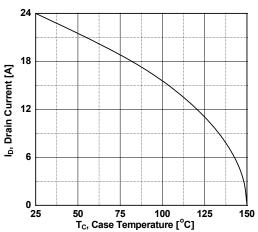
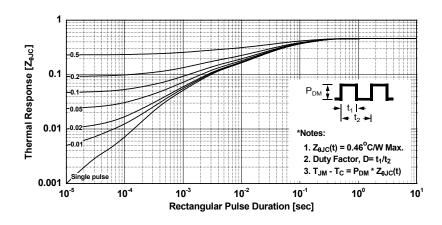
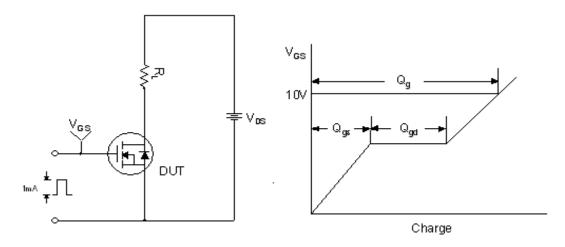


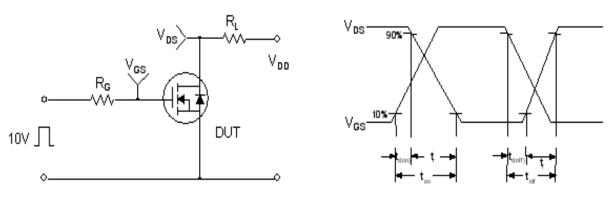
Figure 11. Transient Thermal Response Curve



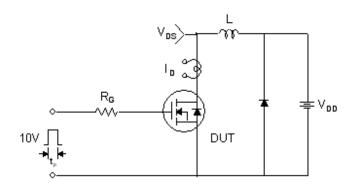
# **Gate Charge Test Circuit & Waveform**

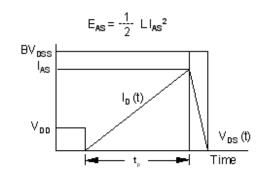


## **Resistive Switching Test Circuit & Waveforms**

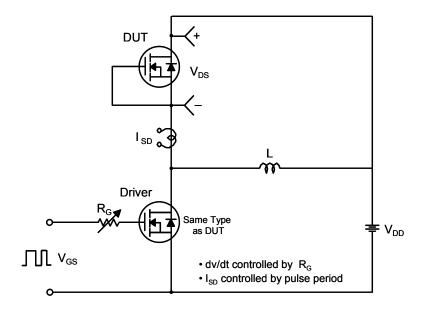


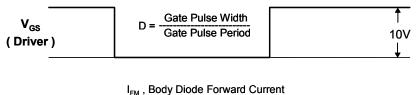
**Unclamped Inductive Switching Test Circuit & Waveforms** 

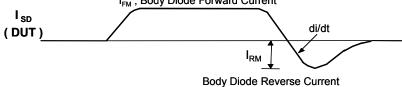


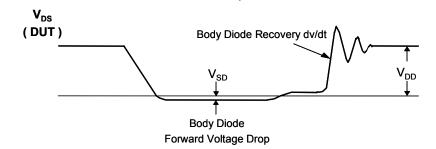


### Peak Diode Recovery dv/dt Test Circuit & Waveforms



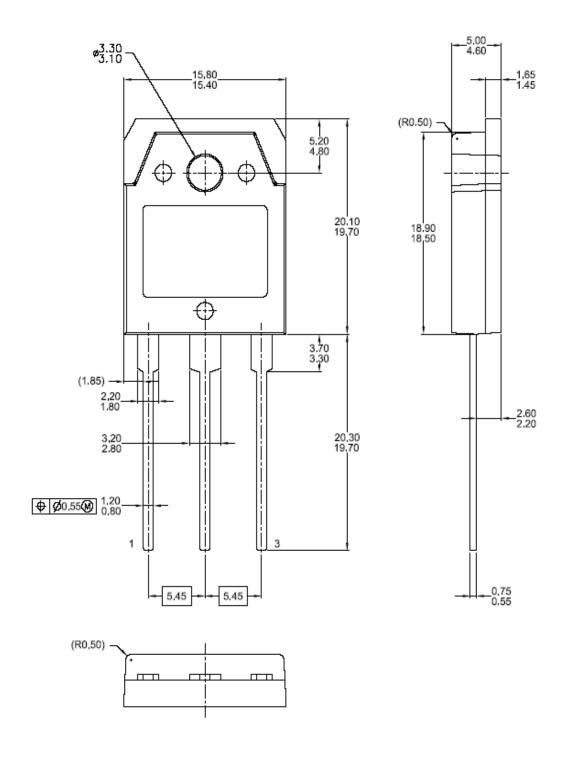






# **Mechanical Dimensions**

# TO-3PN







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